

MOS FIELD EFFECT TRANSISTOR **2SK3221**

SWITCHING N-CHANNEL POWER MOS FET

DESCRIPTION

The 2SK3221 is N-channel DMOS FET device that features a low gate charge and excellent switching characteristics, and designed for high voltage applications such as switching power supply, AC adapter.

FEATURES

· Low gate charge

 $Q_G = 9 \text{ nC TYP}$. (VDD = 450 V, VGS = 10 V, ID = 2.0 A)

- Gate voltage rating ±30 V
- Low on-state resistance

 $R_{DS(on)} = 4.4 \Omega MAX. (V_{GS} = 10 V, I_{D} = 1.0 A)$

- Avalanche capability ratings
- Isolated TO-220 package

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	VDSS	600	V
Gate to Source Voltage (VDS = 0 V)	Vgss	±30	V
Drain Current (DC) (Tc = 25°C)	D(DC)	±2.0	А
Drain Current (pulse) ^{Note1}	D(pulse)	±8.0	А
Total Power Dissipation (T _A = 25°C)	P T1	2.0	W
Total Power Dissipation (Tc = 25°C)	P _{T2}	25	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	–55 to +150	°C
Single Avalanche Current Note2	las	2.0	А
Single Avalanche Energy Note2	Eas	2.7	mJ
Diode Recovery dv/dt Note3	dv/dt	3.5	V/ns

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

- **2.** Starting T_{ch} = 25°C, V_{DD} = 150 V, R_G = 25 Ω , V_{GS} = 20 \rightarrow 0 V
- 3. IF \leq 1.0 A, V_{clamp} = 600 V, di/dt \leq 100 A/ μ s, T_A = 25°C

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ORDERING INFORMATION

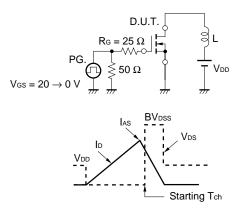
PART NUMBER	PACKAGE		
2SK3211	Isolated TO-220		

ELECTRICAL CHARACTERISTICS (TA = 25°C)

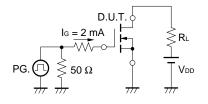
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	Vds = 600 V, Vgs = 0 V			100	μA
Gate Leakage Current	lgss	$V_{GS} = \pm 30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±10	μA
Gate Cut-off Voltage	VGS(off)	V _{DS} = 10 V, I _D = 1 mA	2.5		3.5	V
Forward Transfer Admittance	y _{fs}	VDS = 10 V, ID = 1.0 A	0.5			S
Drain to Source On-state Resistance	RDS(on)	Vgs = 10 V, Id = 1.0 A		3.3	4.4	Ω
Input Capacitance	Ciss	V _{DS} = 10 V		290		pF
Output Capacitance	Coss	Vgs = 0 V		60		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		5		pF
Turn-on Delay Time	td(on)	VDD = 150 V, ID = 1.0 A		7		ns
Rise Time	tr	Vgs = 10 V		2		ns
Turn-off Delay Time	td(off)	R _G = 10 Ω		20		ns
Fall Time	tr			10		ns
Total Gate Charge	QG	V _{DD} = 450 V		9		nC
Gate to Source Charge	Q _{GS}	Vgs = 10 V		2.4		nC
Gate to Drain Charge	Qgd	ID = 2.0 A		2		nC
Body Diode Forward Voltage	VF(S-D)	IF = 2.0 A, VGs = 0 V		0.9		V
Reverse Recovery Time	trr	IF = 2.0 A, VGS = 0 V		0.9		μs
Reverse Recovery Charge	Qrr	di/dt = 50 A/ μs		2.0		μC

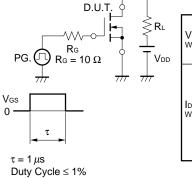
TEST CIRCUIT 1 AVALANCHE CAPABILITY

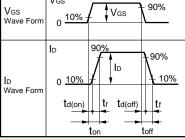
TEST CIRCUIT 2 SWITCHING TIME



TEST CIRCUIT 3 GATE CHARGE

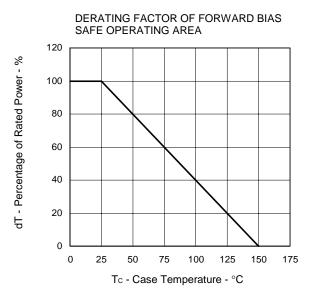




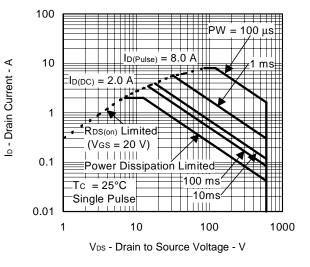


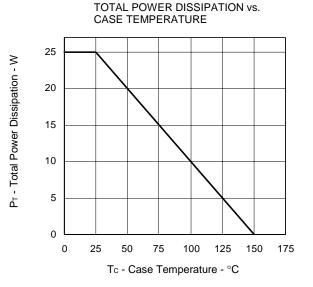
Vgs

TYPICAL CHARACTERISTICS ($T_A = 25^{\circ}C$)

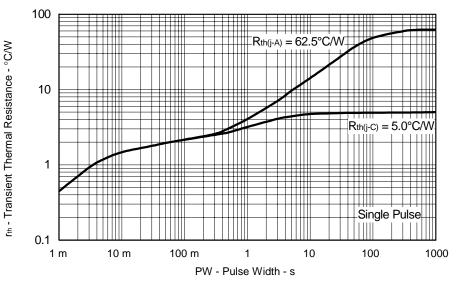


FORWARD BIAS SAFE OPERATING AREA

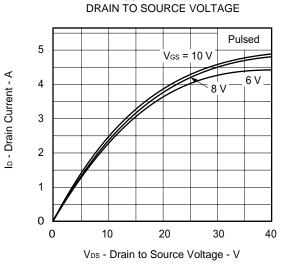




TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

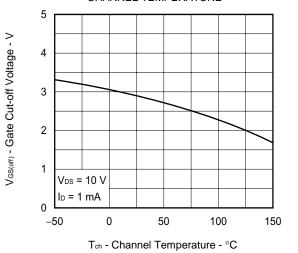


Data Sheet D13789EJ1V0DS

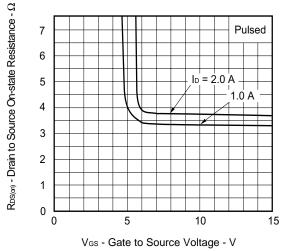




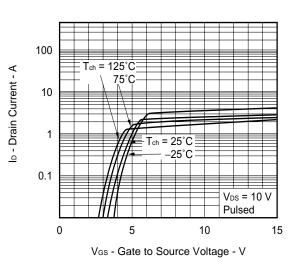


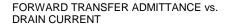


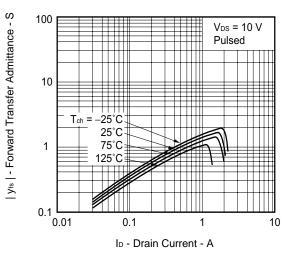
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

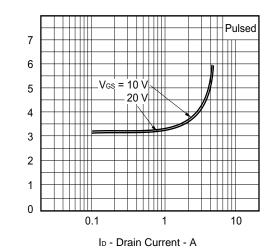


FORWARD TRANSFER CHARACTERISTICS







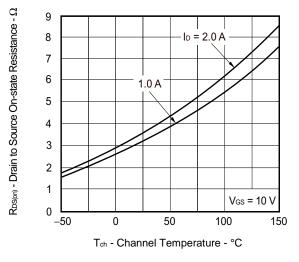


DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

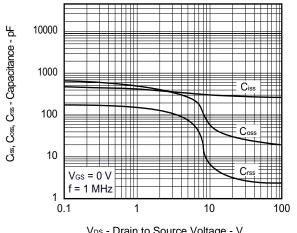
Data Sheet D13789EJ1V0DS

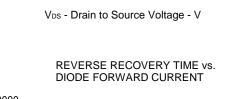
 $R_{DS(cn)}$ - Drain to Source On-state Resistance - Ω

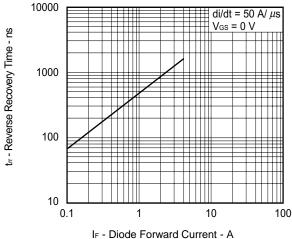
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



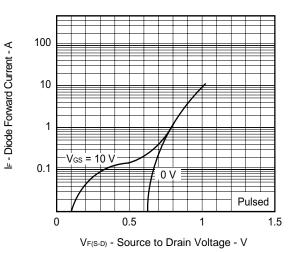




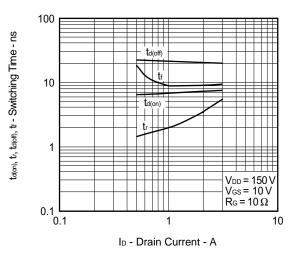




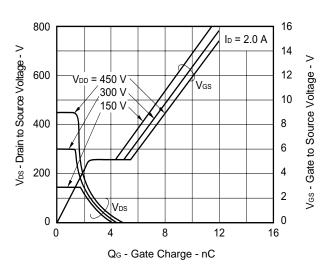
SOURCE TO DRAIN DIODE FORWARD VOLTAGE



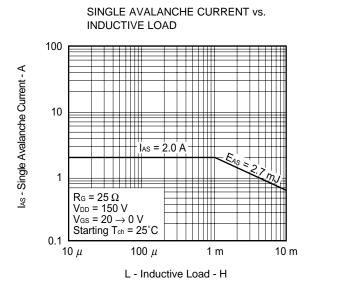
SWITCHING CHARACTERISTICS

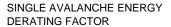


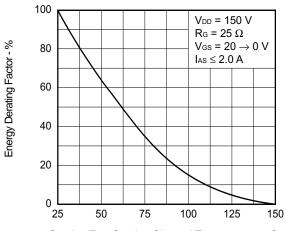




Data Sheet D13789EJ1V0DS

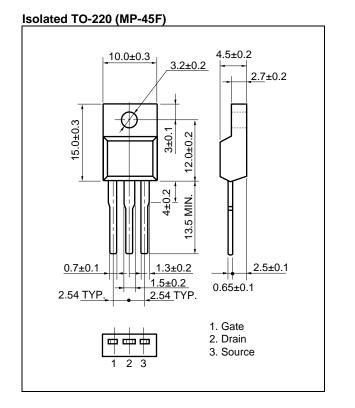




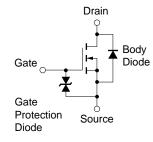


Starting T_{ch} - Starting Channel Temperature - °C

PACKAGE DRAWING (Unit: mm)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

- The information in this document is current as of June, 2002. The information is subject to change
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